


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>10731516</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>JONES ET AL.</p>
	<p>Examiner</p> <p>LAURIE RIES</p>	<p>Art Unit</p> <p>2176</p>

SEARCHED			
Class	Subclass	Date	Examiner
715	236	5/29/2008	LR
715	234	5/29/2008	LR
715	249	5/29/2008	LR
707	102	5/29/2008	LR

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Database Search	4/29/2008	LR
Inventor Name Search (for Double Patenting)	4/29/2008	LR
EAST (US Pat, US PGPub, EPO, JPO) See attached search history	5/29/2008	LR
NPL (Google) See attached search history	5/29/2008	LR
NPL (ACM) See attached search history	5/29/2008	LR
NPL (IEEE Xplore) See attached search history	5/29/2008	LR
Electronic Interference Search (See attached search history)	5/29/2008	LR

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
715	236	5/29/2008	LR
715	249	5/29/2008	LR
707	102	5/29/2008	LR